## Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Please cancel claims 7 through 12 without prejudice or disclaimer.

Please rewrite claims 1-3 and 5 as follows:

## Listing of Claims:

Claim 1 (Currently Amended): A method for fabricating a III-V nitride film, comprising the steps of:

preparing providing a horizontal reactor horizontally[[,]]:

setting a substrate onto a susceptor installed in the reactor[[,]];

heating the substrate to a predetermined temperature[[,]];

directly cooling at least [[the]] a portion of the inner wall of the reactor directly opposite to the substrate[[,]]; and

introducing a [[III]] raw III material gas and a [[V]] raw V material gas with a carrier gas onto the substrate, and thus, fabricating to form a III-V nitride film [[by]] using a MOCVD method.

Claim 2 (Currently Amended): A fabricating method as defined in claim 1, wherein the susceptor is set on the bottom wall of the reactor, and the opposite a portion of the top wall of the reactor opposite to the substrate set on the susceptor is cooled down.

Claim 3 (Currently Amended): A fabricating method as defined in claim 1, wherein [[the]] an upper stream side of the reactor from with respect to the substrate set on the susceptor is cooled down.

Claim 4 (Original): A fabricating method as defined in claim 1, wherein the whole of the reactor is cooled down.

Claim 5 (Currently Amended): A fabricating method as defined in claim 1, wherein the III-V nitride film is an Al-rich AlxGaylnzN  $Al_xGa_yIn_xN$  (x+y+z=1, x>0.5, y≥0, Z≥0) film.

Claim 6 (Original): A fabricating method as defined in claim 1, wherein the III-V nitride film is an AlN film.

Claims 7-12 (Cancelled).